

## Notice of References Cited

	Application/Control No. 10/085,381	ン	Applicant(s)/Patent Under Reexamination TERADA ET AL.		
	Examiner		Art Unit		
ļ	Ahshik Kim		2876	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,363,352	03-2002	Dailey et al.	705/9
	В	US-6,488,205	12-2002	Jacobson, Howard John	235/380
	С	US-6,378,771	04-2002	Cooper, James R.	235/382
	D	US-6,422,463	07-2002	Flink, Jonathan C.	235/382
	E	US-6,220,512	04-2001	Cooper, James R.	235/382
	F	US-6,389,454	05-2002	Ralston et al.	709/204
	G	US-5,947,369	09-1999	Frommer et al.	235/382
	Н	US-5,877,483	03-1999	Bilich et al.	235/382
	1	US-5,604,640	02-1997	Zipf et al.	359/803
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S				***	
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.